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Applications of Computer Vision

Guest Editor:

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Deadline for manuscript submissions:

closed (20 March 2022)

Message from the Guest Editor

Dear Colleagues,

Computer vision (CV) techniques are widely used by the practicing engineer to solve a whole range of real vision problems. Our aim is to encourage scientists to publish their experimental and theoretical results in as much detail as possible, covering some practical application of CV methods in all branches of science and engineering. Submitted papers should report some novel aspect of CV use for a real-world engineering application and also validated using data sets. There is no restriction on the length of the papers. Electronic files and software regarding the full details of the calculation or experimental procedure, if unable to be published in a normal way, can be deposited as supplementary electronic material.

Focal points of the Special Issue include but are not limited to innovative applications of:

- Medical and biological imaging
- Industrial inspection
- Robotics
- Photo and video interpretation
- Image retrieval
- Video analysis and annotation
- Multimedia
- Sensors and more.











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Editor-in-Chief

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Message from the Editor-in-Chief

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